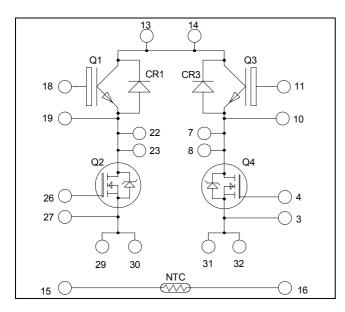


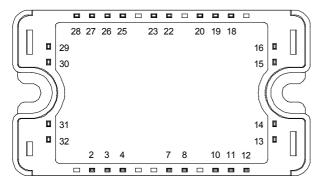
Full - Bridge NPT & Trench + Field Stop IGBT3 Power module Trench & Field Stop IGBT3 Q1, Q3: $V_{CES} = 600V$; $I_C = 50A$ @ $Tc = 80^{\circ}C$

CoolMOSTM Q2, Q4:

 $V_{CES} = 600V$; $I_C = 49A$ @ $T_C = 25$ °C



Top switches: Trench + Field Stop IGBT3
Bottom switches: CoolMOSTM



All multiple inputs and outputs must be shorted together 13/14; 15/16; 26/27; 31/32

Application

Solar converter

Features

- Q2, Q4 CoolMOSTM
 - Ultra low R_{DSon}
 - Low Miller capacitance
 - Ultra low gate charge
 - Avalanche energy rated
- Q1, Q3 Trench & Field Stop IGBT3
 - Low voltage drop
 - Switching frequency up to 20 kHz
 - RBSOA & SCSOA rated
 - Low tail current
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

Benefits

- Optimized conduction & switching losses
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive T_C of V_{CEsat}
- RoHS Compliant

All ratings @ $T_i = 25^{\circ}C$ unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handing Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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1. Top switches

1.1 Top Trench + Field Stop IGBT3 characteristics

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V_{CES}	Collector - Emitter Breakdown Voltage		600	V
I_{C}	Continuous Collector Current	$T_C = 25^{\circ}C$	80	
	T _C =	$T_C = 80$ °C	50	A
I_{CM}	Pulsed Collector Current	$T_C = 25$ °C	100	
V_{GE}	Gate – Emitter Voltage		±20	V
P_{D}	Maximum Power Dissipation	$T_C = 25^{\circ}C$	176	W
RBSOA	Reverse Bias Safe Operating Area	$T_{\rm J} = 150^{\circ}{\rm C}$	100A @ 550V	

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$				250	μA
V _{CE(sat)}	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25$ °C		1.5	1.9	V
		$I_C = 50A$ $T_j = 13$	$T_j = 150$ °C		1.7		v
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 600 \mu A$		5.0	5.8	6.5	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE}$	$V_{GE} = 20V, V_{CE} = 0V$			600	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	1	Min	Typ	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$			3150		
Coes	Output Capacitance	$V_{CE} = 25V$			200		pF
C_{res}	Reverse Transfer Capacitance	f = 1MHz			95		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switch	hing (25°C)		110		
T _r	Rise Time	$V_{GE} = \pm 15V$			45		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 300 \text{V}$ $I_{\text{C}} = 50 \text{A}$			200		ns
$T_{\rm f}$	Fall Time	$R_G = 8.2\Omega$		40			
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C)			120		
T_{r}	Rise Time	$V_{GE} = \pm 15V$			50		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 300V$ $I_C = 50A$			250		ns
T_{f}	Fall Time	$R_G = 8.2\Omega$	C		60		
Б	Turn-on Switching Energy	$V_{GE} = \pm 15V$	$T_j = 25^{\circ}C$		0.3		mJ
Eon	Turn-on Switching Energy	$V_{\text{Bus}} = 300V$	$T_{j} = 150^{\circ}C$		0.43		1113
E_{off}	Turn-off Switching Energy	$I_{\rm C} = 50A$	$T_j = 25$ °C		1.35		mJ
-OII	Tam on Switching Energy	$R_G = 8.2\Omega$	$R_G = 8.202$ $T_i = 150^{\circ}C$		1.75		1110
R_{thJC}	Junction to Case Thermal resistance					0.85	°C/W



1.2 Top fast diode characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V
I_{RM}	Maximum Reverse Leakage Current	$V_R=600V$	$T_j = 25^{\circ}C$			25	μA
1 _{RM}	Maximum Reverse Leakage Current	V R−000 V	$T_{j} = 125^{\circ}C$			500	μΛ
I_{F}	DC Forward Current		$Tc = 80^{\circ}C$		30		A
	Diode Forward Voltage	$I_F = 30A$			1.8	2.3	
V_{F}		$I_F = 60A$			2.1		V
		$I_F = 30A$	$T_j = 125$ °C		1.5		
t _{rr}	Reverse Recovery Time		$T_j = 25$ °C		25		ns
·rr		$I_F = 30A$ $V_R = 400V$	$T_{j} = 125^{\circ}C$		160		113
Q_{rr}	Reverse Recovery Charge	$di/dt = 200 \text{ A/} \mu \text{s}$	$T_j = 25$ °C		35		nC
V rr	Reverse Recovery Charge	·	$T_j = 125$ °C		480		iic
R_{thJC}	Junction to Case Thermal resistance		•			1.2	°C/W

2. Bottom switches

2.1 Bottom CoolMOSTM characteristics

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		600	V
I_D	Continuous Drain Current	$T_c = 25^{\circ}C$	49	
	Continuous Drain Current $T_c = 80^\circ$		38	Α
I_{DM}	Pulsed Drain current		130	
V_{GS}	Gate - Source Voltage		±20	V
R_{DSon}	Drain - Source ON Resistance		45	mΩ
P_{D}	Maximum Power Dissipation	$T_c = 25$ °C	290	W
I_{AR}	Avalanche current (repetitive and non repetitive)		15	A
E_{AR}	Repetitive Avalanche Energy		3	mJ
E_{AS}	Single Pulse Avalanche Energy		1900	1113

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit	
т	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 600V$ $T_j = 100$	= 25°C			250	μA	
I_{DSS}		$V_{GS} = 0V, V_{DS} = 600V$ $T_j =$	= 125°C			500	μА	
R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 24.5A$			40	45	mΩ	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 3mA$		2.1	3	3.9	V	
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA	

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Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V ; V_{DS} = 25V$		7.2		nF
C_{rss}	Reverse Transfer Capacitance	f = 1MHz		0.29		111
Q_{g}	Total gate Charge	$V_{GS} = 10V$		150		
Q_{gs}	Gate – Source Charge	$V_{Bus} = 300V$		34		nC
Q_{gd}	Gate – Drain Charge	$I_D = 49A$		51		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)		21		
$T_{\rm r}$	Rise Time	$V_{GS} = 10V$		30		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 400V$ $I_{\text{D}} = 49A$		100		ns
T_{f}	Fall Time	$R_G = 4.7\Omega$		45		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C $V_{GS} = 10V$; $V_{Bus} = 400V$		675		μJ
E_{off}	Turn-off Switching Energy	$I_{\rm D} = 49 \text{A} \; ; \; R_{\rm G} = 4.7 \Omega$		520		μυ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C		1100		1
E_{off}	Turn-off Switching Energy	$-V_{GS} = 10V$; $V_{Bus} = 400V$ $I_D = 49A$; $R_G = 4.7Ω$		635		μJ
R_{thJC}	Junction to Case Thermal resistance				0.5	°C/W

3. Temperature sensor

NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K

$$R_T = \frac{R_{25}}{\exp\!\left[B_{25/85}\!\left(\frac{1}{T_{25}}\!-\!\frac{1}{T}\right)\right]} \quad \text{T: Thermistor temperature} \\ R_T: \text{Thermistor value at T}$$

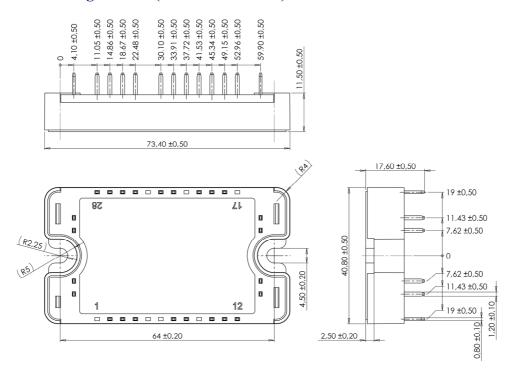
4. Package characteristics

Symbol	Characteristic		Min	Тур	Max	Unit	
V_{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T_J	Operating junction temperature range			-40		150*	
T_{STG}	Storage Temperature Range			-40		125	°C
T_{C}	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight				·	110	g

Tj=175°C for Trench & Field Stop IGBT3



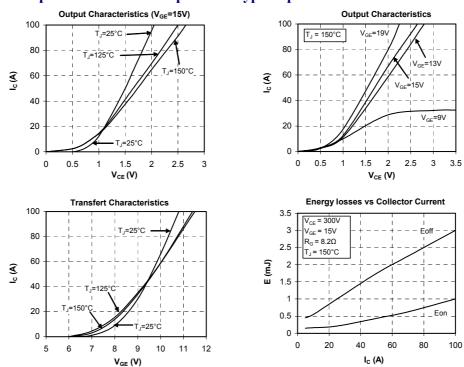
5. SP3 Package outline (dimensions in mm)



See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

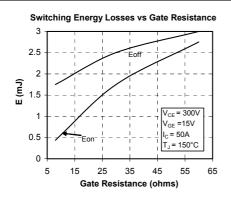
6. Top switches curves

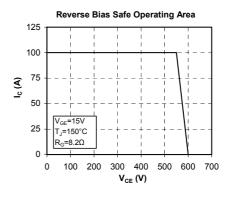
6.1 Top Trench + Field Stop IGBT3 typical performance curves

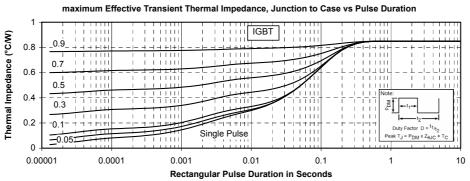


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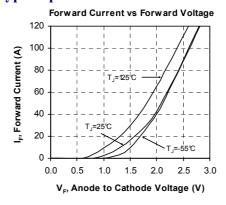


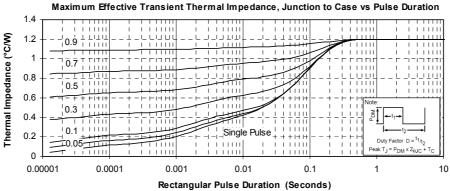






6.2 Top Fast diode typical performance curves



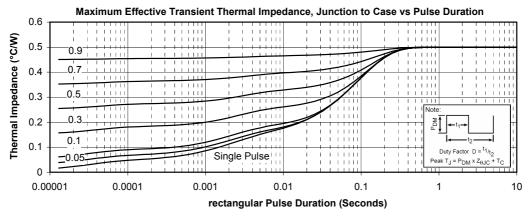


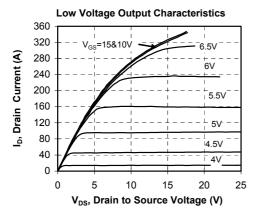
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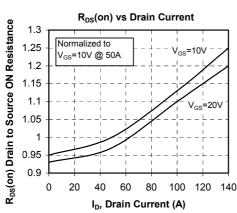


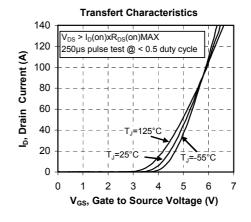
7. Bottom switches curves

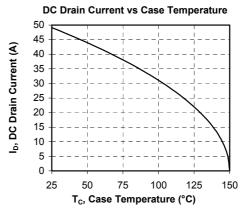
7.1 Bottom CoolMOSTM typical performance curves



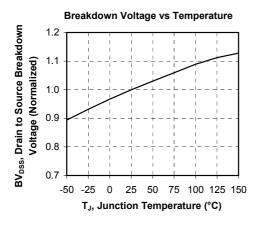


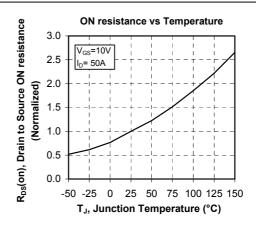


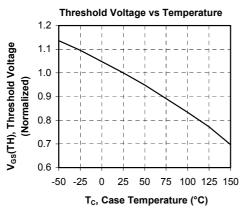


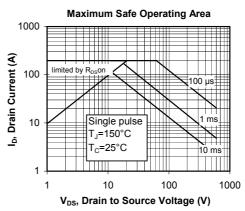


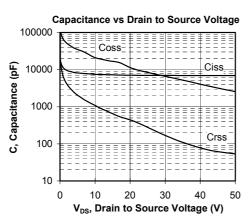


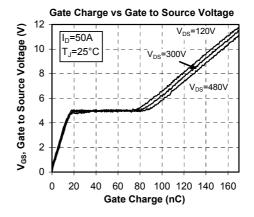




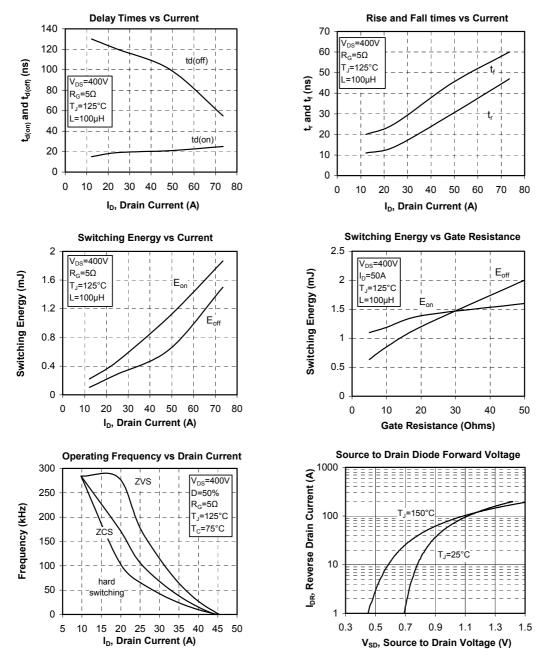












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